Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13913-161001	Application No. 10/657,709
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR 1.98(b))		Applicant Gerd Kluger et al.	
		Filing Date September 9, 2003	Group Art Unit Unknown

U.S. Patent Documents
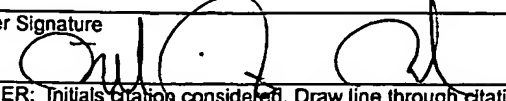
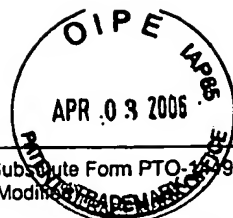| Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
✓	AA	5,293,630	03/08/94	Tatge, et al.			
✓	AB	5,371,891	12/06/94	Gray, et al.			
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✓	AD	6,052,526	04/18/00	Chatt			
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✓	AF	6,145,120	11/07/00	Highland			
✓	AG	6,446,259 B2	09/03/02	Brett			
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes	Translation No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
✓	AQ	Keller, H. and Jacobitz, J., "ABAP Objects – The Official Reference", SAP Press, Vol. 1, 2003 (cover and title page; pp. 89-95 and 186-192 (10 sheets))
	AR	
	AS	
	AT	

Examiner Signature	Date Considered 1/12/07

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Disclosure Form (PTO-1449)

APR 0 3 2006

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13913-161001	Application No. 10/657,709
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Gerd Kluger et al.	
		Filing Date September 9, 2003	Group Art Unit 2122

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes	Translation No
	AH							
	AI							
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	AL							

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✓	AN	Richter, "Microsoft.NET Framework Delivers the Platform for an Integrated, Service-Oriented Web", MSDN Magazine, September, 2000, retrieved from the internet http://msdn.microsfot.com/msdnmag/issues/0900/framework/ on January 25, 2006
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	AQ	

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